

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L3	1	((adjust\$3 with (increment incrementally) with threshold\$3 with parameter) same (report\$3 with defect) same (critical with defect)) and (subtract\$3 with (increment ncrementally) with threshold\$3 with parameter)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/10/14 12:17
L4	1	((adjust\$3 with (increment incrementally) with threshold\$3 with parameter) same (report\$3 with defect) same (critical with defect)) and (subtract\$3 with (increment ncrementally) with threshold\$3 with parameter)	US-PGPUB	OR	ON	2005/10/14 12:18
L5	1	((adjust\$3 with (increment incrementally) with threshold\$3 with parameter) same (report\$3 with defect) same (critical with defect)) and (subtract\$3 with (increment ncrementally) with threshold\$3 with parameter)).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 12:17
L6	1	((adjust\$3 with (increment incrementally) with threshold\$3 with parameter) same (report\$3 with defect) same (critical with defect)) and (subtract\$3 with (increment ncrementally) with threshold\$3 with parameter)).clm.	US-PGPUB	OR	ON	2005/10/14 12:17
L7	1	("702"/\$.ccls. "700"/\$.ccls. "324"/\$.ccls. "349"/\$.ccls.) and ((adjust\$3 with (increment incrementally) with threshold\$3 with parameter) same (report\$3 with defect) same (critical with defect)) and (subtract\$3 with (increment ncrementally) with threshold\$3 with parameter))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 12:19
L8	1	("702"/\$.ccls. "700"/\$.ccls. "324"/\$.ccls. "349"/\$.ccls.) and ((adjust\$3 with (increment incrementally) with threshold\$3 with parameter) same (report\$3 with defect) same (critical with defect)) and (subtract\$3 with (increment ncrementally) with threshold\$3 with parameter))	US-PGPUB	OR	ON	2005/10/14 12:19
S1	1	10/642617	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 12:41

S3	11	10/355059	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 16:28
S4	4296	TFT-array or (TFT near1 array)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 16:29
S5	145	(TFT-array or (TFT near1 array)) with test\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:33
S6	30	S5 and (pixel with defective)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 16:59
S7	13	S6 and (critical with number with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:24
S8	13	S6 and (critical with number)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 16:44
S9	13	S6 and (critical with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 16:33
S10	12	program\$6 and defect\$3 and (electrode with array with test\$3) and pixels and (defect\$3 with report) and (critical with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 17:01
S11	12	defect\$3 and (electrode with array with test\$3) and pixels and (defect\$3 with report) and (number with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 17:02
S12	12	defect\$3 and (electrode with array with test\$3) and (defect\$3 with report) and (number with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/18 17:04

S13	13	(electrode with array with test\$3) and (defect\$3 with report) and ((adjust\$3 compar\$6 calibrat\$3) with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:35
S14	22	(electrode with array with test\$3) and (defect\$3 with pixel) and ((adjust\$3 compar\$6 calibrat\$3) with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:04
S15	20	S14 and (defect\$3 with number)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 17:15
S16	145	(TFT-array or (TFT near1 array)) with test\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 14:08
S17	16	S16 and (number with defect\$3 with pixel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:26
S18	3	"702"/\$.ccls. and (LCD with test\$3) and (array with test\$3) and (number with defect\$3 with pixel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:48
S19	16	S16 and (array with test\$3) and (number with defect\$3 with pixel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:50
S20	4	("4983911" "5179345").pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:49
S21	0	S20 and (array with test\$3) and (number with defect\$3 with pixel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:51
S22	0	S20 and array and (defect\$3 with pixel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:52

S23	0	S20 and (defect\$3 with pixel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:51
S24	1	S20 and array and pixel	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:52
S25	1	S24 and test\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 16:52
S26	11	program and (number with defect\$3 with report\$3) and (electrode with array with test\$3) and (number with defect\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 17:17
S27	27	program\$6 and (number with defect\$3) and report\$3 and (electrode with array with test\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 17:19
S28	11	(program\$6 with test\$3) and (defect\$3 with report\$3) and (electrode with array with test\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/19 17:39
S30	17	(TFT-array or (TFT near1 array)) with test\$3 and (computer with program\$6)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 14:09
S31	16	S30 and defect\$3 and electrode	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/21 06:18
S32	5	(TFT-array or (TFT near1 array)) with test\$3 and (compar\$3 with defect\$3) and (adjust\$3 with parameter)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:50
S33	5	(electrode with array with test\$3) and (compar\$3 with defect\$3) and (adjust\$3 with parameter)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:46

S34	0	"702"/\$.ccls. and (eletrode with array with test\$3) and compar\$3 and (adjust\$3 with parameter)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:47
S35	0	"702"/\$.ccls. and (electrode with array with test\$3) and compar\$3 and (adjust\$3 with parameter)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/10/14 12:08
S36	5	"702"/\$.ccls. and (electrode with array with test\$3) and (array with test\$3) and (defect\$3 with pixel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:49
S37	13	("4175253" "4290013" "4342959" "4801869" "4819038" "4843312" "4894605" "4940934" "5057775" "5072175" "5113134" "5179345" "5377030").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/03/20 15:50
S38	0	S37 and (compar\$3 with defect\$3) and (adjust\$3 with parameter)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:50
S39	0	S37 and compar\$3 and defect\$3 and (adjust\$3 with parameter)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/20 15:50
S40	17	(TFT-array or (TFT near1 array)) with test\$3 and (computer with program\$6)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/21 06:18
S41	15	S40 and (pixel with defect\$3) and electrode	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/21 06:19
S42	18	(electrode with array with test\$3) and (pixel with defect\$3) and program\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/03/21 06:25